

Search Notes

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Examiner

Khanh V. Nguyen

Applicant(s)/Patent under
Reexamination

FUJISE, TAKASHI

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	8/22/2005	NKV